

Search Notes

Application/Control No.

10/670,618

Examiner

Benjamin Huh

Applicant(s)/Patent under
Reexamination

FLOCK ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner
604	20, 22, 27, 31-32, 37- 40,82-84	5/23/2006	BHH
606	4	5/23/2006	BHH
606	41-49	5/23/2006	BHH
604	503	5/23/2006	BHH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/23/2006	BHH
Search Updated	5/23/2006	BHH